## Notice of References Cited Application/Control No. 10/598,903 Examiner Alexander O. Williams Applicant(s)/Patent Under Reexamination FUKUSAKO ET AL. Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2008/0101032 A1	05-2008	Tschirbs et al.	361/719
*	В	US-2008/0037223 A1	02-2008	Muller et al.	361/710
*	С	US-6,304,450 B1	10-2001	Dibene et al.	361/704
*	D	US-2007/0278669 A1	12-2007	Hierholzer et al.	257/718
*	Е	US-2006/0198106 A1	09-2006	You, Se Joon	361/702
*	F	US-2006/0006405 A1	01-2006	Mazzochette, Joseph	257/099
*	G	US-2001/0014029 A1	08-2001	Suzuki et al.	363/141
*	Η	US-7,344,345 B2	03-2008	Aukzemas, Thomas V.	411/372
*	I	US-7,342,796 B2	03-2008	Aukzemas, Thomas V.	361/719
*	J	US-6,845,014 B2	01-2005	Wakabayashi et al.	361/719
*	K	US-5,721,602	02-1998	Narayan et al.	349/161
	L	US-			
_	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	W	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.